



16-Ch/Dual 8-Ch High-Performance CMOS Analog Multiplexers

DESCRIPTION

The DG406 is a 16-channel single-ended analog multiplexer designed to connect one of sixteen inputs to a common output as determined by a 4-bit binary address. The DG407 selects one of eight differential inputs to a common differential output. Break-before-make switching action protects against momentary shorting of inputs.

An on channel conducts current equally well in both directions. In the off state each channel blocks voltages up to the power supply rails. An enable (EN) function allows the user to reset the multiplexer/demultiplexer to all switches off for stacking several devices. All control inputs, address (A_x) and enable (EN) are TTL compatible over the full specified operating temperature range.

Applications for the DG406/407 include high speed data acquisition, audio signal switching and routing, ATE systems, and avionics. High performance and low power dissipation make them ideal for battery operated and remote instrumentation applications. For additional application information order Faxback document numbers 70601 and 70604.

Designed in the 44 V silicon-gate CMOS process, the absolute maximum voltage rating is extended to 44 volts, allowing operation with $\pm~20$ V supplies. Additionally single (12 V) supply operation is allowed. An epitaxial layer prevents latchup.

For applications information please request FaxBack documents 70601 and 70604.

FEATURES

- Low On-Resistance r_{DS(on)}: 50 Ω
- · Low Charge Injection Q: 15 pC
- Fast Transition Time t_{TRANS}: 200 ns
- Low Power: 0.2 mW
- Single Supply Capability
- 44 V Supply Max Rating

Pb-free Available



BENEFITS

- Higher Accuracy
- Reduced Glitching
- Improved Data Throughput
- Reduced Power Consumption
- · Increased Ruggedness
- Wide Supply Ranges: ± 5 V to ± 20 V

APPLICATIONS

- Data Acquisition Systems
- · Audio Signal Routing
- · Medical Instrumentation
- · ATE Systems
- Battery Powered Systems
- High-Rel Systems
- · Single Supply Systems

FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION

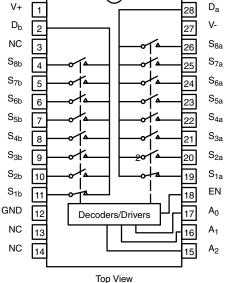
DG406 Dual-In-Line and SOIC Wide-Body D V+ 28 NC V-2 NC S_8 26 S_{16} S_7 S₁₅ S_6 24 S₁₄ S_5 6 S₁₃ S_4 S_3 S_{12} 8 21 S₁₁ S_2 9 20 S₁₀ S_1 19 S_9 ΕN 18 11 GND A_0 17 Decoders/Drivers NC A₁ 16 A_3 A_2

DG407 Dual-In-Line and SOIC Wide-Body

V+ 1

Db 2

28

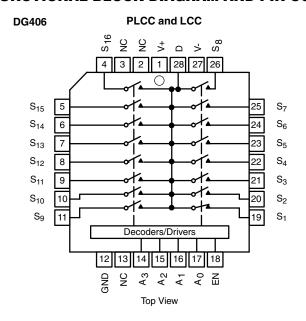


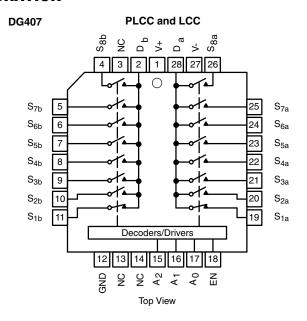
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^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

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FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION





TRUTH TABLE - DG406									
A ₃	A ₂	A ₁	A ₀	EN	On Switch				
Х	Х	Х	Х	0	None				
0	0	0	0	1	1				
0	0	0	1	1	2				
0	0	1	0	1	3				
0	0	1	1	1	4				
0	1	0	0	1	5				
0	1	0	1	1	6				
0	1	1	0	1	7				
0	1	1	1	1	8				
1	0	0	0	1	9				
1	0	0	1	1	10				
1	0	1	0	1	11				
1	0	1	1	1	12				
1	1	0	0	1	13				
1	1	0	1	1	14				
1	1	1	0	1	15				
1	1	1	1	1	16				

TRUTH TABLE - DG407								
A ₂	A ₁	A ₀	EN	On Switch Pair				
Х	Х	Х	0	None				
0	0	0	1	1				
0	0	1	1	2				
0	1	0	1	3				
0	1	1	1	4				
1	0	0	1	5				
1	0	1	1	6				
1	1	0	1	7				
1	1	1	1	8				

 $\begin{array}{l} \text{Logic "0"} = V_{AL} \leq 0.8 \text{ V} \\ \text{Logic "1"} = V_{AH} \geq 2.4 \text{ V} \\ \text{X} = \text{Do not Care} \end{array}$

ORDERING INFORMATION - DG406									
Temp Range Package Part Number									
	28-Pin Plastic DIP	DG406DJ DG406DJ-E3							
- 40 to 85 °C	28-Pin PLCC	DG406DN DG406DN-T1-E3							
	28-Pin Widebody SOIC	DG406DW DG406DW-E3							

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ABSOLUTE MAXIMUM RATINGS							
Parameter		Limit	Unit				
Voltages Referenced to V-	V+	44					
voltages helefeliced to v-	GND	25	V				
Digital Inputs ^a , V _S , V _D		(V-) - 2 V to (V+) + 2 V or 20 mA, whichever occurs first]				
Current (Any Terminal)		30	mA				
Peak Current, S or D (Pulsed at	1 ms, 10 % Duty Cycle Max)	100	IIIA				
Storage Temperature	(AK, AZ Suffix)	- 65 to 150	°C				
Storage remperature	(DJ, DN Suffix)	- 65 to 125					
	28-Pin Plastic DIP ^b	625	mW				
	28-Pin CerDIP ^d	1.2	W				
Power Dissipation (Package) ^b	28-Pin Plastic PLCC ^c	450	mW				
	LCC-28 ^e	1.35	W				
	28-Pin Widebody SOIC	450	mW				

Notes:

- a. Signals on SX, DX or INX exceeding V+ or V- will be clamped by internal diodes. Limit forward diode current to maximum current ratings. b. All leads soldered or welded to PC board.
- c. Derate 6 mW/°C above 75°C.
- d. Derate 12 mW/°C above 75°C.
- e. Derate 13.5 mW/°C above 75°C .

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		Test Condition Unless Otherwise S V+ = 15 V, V- = -	pecified				uffix 125 °C	D Suffix - 40 to 85 °C		
Parameter	Symbol	$V_{AL} = 15 \text{ V}, V_{AH} = 15 \text{ V}$		Temp ^b	Тур ^с	Min ^d	Max ^d	Min ^d	Max ^d	Unit
Analog Switch	Зуппоп	TAL OIG 1, TAH		Tellip	ТУР	IVIIII	IVIAX	IVIIII	IVIAA	Oiiit
Analog Signal Range ^e	V _{ANALOG}			Full		- 15	15	- 15	15	V
Drain-Source On-Resistance	r _{DS(on)}	$V_D = \pm 10 \text{ V}, I_S = -$ Sequence Each Sw		Room Full	50		100 125		100 125	Ω
r _{DS(on)} Matching Between Channels ^g	$\Delta r_{DS(on)}$	V _D = ± 10 V		Room	5					%
Source Off Leakage Current	I _{S(off)}	V _{EN} = 0 V		Room Full	0.01	- 0.5 - 50	0.5 50	- 0.5 - 5	0.5 5	
Drain Off Leakage Current	I _{D(off)}	$V_D = \pm 10 \text{ V}$ $V_S = \pm 10 \text{ V}$	DG406	Room Full	0.04	- 1 - 200	1 200	- 1 - 40	1 40	
J .	2(0)	3	DG407	Room Full	0.04	- 1 - 100	100	- 1 - 20	1 20	nA
Drain On Leakage Current	I _{D(on)}	$V_S = V_D = \pm 10$ Sequence Each	DG406	Room Full	0.04	- 1 - 200	200	- 1 - 40	1 40	
	_ (:,	Switch On	DG407	Room Full	0.04	- 1 - 100	1 100	- 1 - 20	1 20	
Digital Control	· · · · · · · · · · · · · · · · · · ·	T			I		I	- 1	I	
Logic High Input Voltage	V _{INH}			Full		2.4	0.0	2.4	0.0	V
Logic Low Input Voltage Logic High Input Current	V _{INL}	V _A = 2.4 V, 15	V	Full Full		- 1	0.8	- 1	0.8	
Logic Low Input Current	I _{AH}	$V_{EN} = 0 \text{ V}, 2.4 \text{ V}, V_{ex}$		Full		- 1	1	- 1 - 1	1	μΑ
Logic Input Capacitance	C _{in}	f = 1 MHz		Room	7	'	'			pF
Dynamic Characteristics	- 111			1	l .					J P.
Transition Time	t _{TRANS}	See Figure 2	!	Room Full	200		350 450		350 450	
Break-Before-Make Interval	t _{OPEN}	See Figure 4		Room Full	50	25 10		25 10		
Enable Turn-On Time	t _{ON(EN)}	See Figure 3		Room Full	150		200 400		200 400	ns
Enable Turn-Off Time	t _{OFF(EN)}			Room Full	70		150 300		150 300	
Charge Injection	Q	$V_S = 0 \text{ V, } C_L = 1 \text{ nF, I}$		Room	15					рC
Off Isolation ^h	OIRR	V _{EN} = 0 V, R _L = 100 kHz		Room	- 69					dB
Source Off Capacitance	C _{S(off)}	$V_{EN} = 0 \text{ V}, V_{S} = 0 \text{ V}, f$	= 1 MHz	Room	8					
Drain Off Capacitance	$C_{D(off)}$	$V_{EN} = 0 V$ $V_{D} = 0 V$	DG407	Room Room	130 65					pF
Drain On Capacitance	C _{D(on)}	f = 1 MHz DG406		Room Room	140 70]
Power Supplies					L		L		L	
Positive Supply Current	l+	$V_{EN} = V_A = 0$ or	5 V	Room Full	13		30 75		30 75	
Negative Supply Current	-	$V_{EN} = V_A = 0 \text{ or } 5 \text{ V}$		Room Full	- 0.01	- 1 - 10		- 1 - 10		μΑ
Positive Supply Current	l+	V _{EN} = 2.4 V, V _A =	- 0 V	Room Full	50		500 900		500 700	μ/.
Negative Supply Current	l-	*EN - 2.7 *, *A - 0 *		Room Full	- 0.01	- 20 - 20		- 20 - 20		



SPECIFICATIONS ^a (FOR SINGLE SUPPLY)										
		Test Conditions Unless Otherwise Specified					A Suffix - 55 to 125 °C		D Suffix - 40 to 85 °C	
Parameter	Symbol	V+ = 12 V, V- = 0 $V_{AL} = 0.8 V, V_{AH} = 0$		Temp ^b	Тур ^с	Min ^d	Max ^d	Min ^d	Max ^d	Unit
Analog Switch							l .			
Analog Signal Range ^e	V_{ANALOG}			Full		0	12	0	12	V
Drain-Source On-Resistance	r _{DS(on)}	V _D = 3 V, 10 V, I _S =		Room	90		120		120	Ω
r _{DS(on)} Matching Between Channels ^g	$\Delta r_{DS(on)}$	Sequence Each Swi	tch On	Room	5					%
Source Off Leakage Current	I _{S(off)}	V _{EN} = 0 V		Room	0.01					
Drain Off Leakage Current	la (m	$V_D = 10 \text{ V or } 0.5 \text{ V}$	DG406	Room	0.04					
Diain On Leakage Current	I _{D(off)}	$V_S = 0.5 \text{ V or } 10 \text{ V}$	DG407	Room	0.04					nA
		$V_{S} = V_{D} = \pm 10$	DG406	Room	0.04					
Drain On Leakage Current	I _{D(on)}	Sequence Each Switch On	DG407	Room	0.04					
Dynamic Characteristics										
Switching Time of Multiplexer	t _{OPEN}	$V_{S1} = 8 \text{ V}, V_{S8} = 0 \text{ V}, \text{ V}$	_{IN} = 2.4 V	Room	300		450		450	
Enable Turn-On Time	t _{ON(EN)}	V _{INH} = 2.4 V, V _{INL} :	= 0 V	Room	250		600		600	ns
Enable Turn-Off Time	t _{OFF(EN)}	$V_{S1} = 5 V$		Room	150		300		300	
Charge Injection	Q	$C_L = 1 \text{ nF, } V_S = 6 \text{ V, } R_S = 0$		Room	20					рC
Power Supplies										
Positive Supply Current	l+	V _{EN} = 0 V or 5 V, V _A = 0 V or 5 V		Room Full	13		30 75		30 75	μΑ
Negative Supply Current	l-	VEN - O V OI O V, VA - V	0 V 01 0 V	Room Full	- 0.01	- 20 - 20		- 20 - 20		μΑ

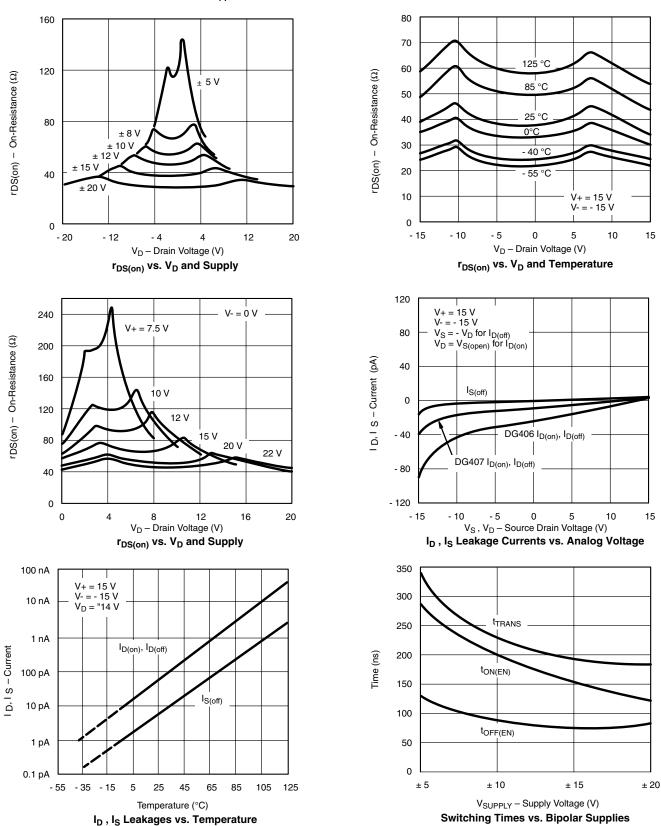
Notes:

- a. Refer to PROCESS OPTION FLOWCHART.
- b. Room = 25 $^{\circ}$ C, Full = as determined by the operating temperature suffix.
- c. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- e. Guaranteed by design, not subject to production test.
- f. V_{IN} = input voltage to perform proper function.
- g. $\Delta r_{DS(on)} = r_{DS(on)}$ MAX $r_{DS(on)}$ MIN. h. Worst case isolation occurs on Channel 4 due to proximity to the drain pin.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

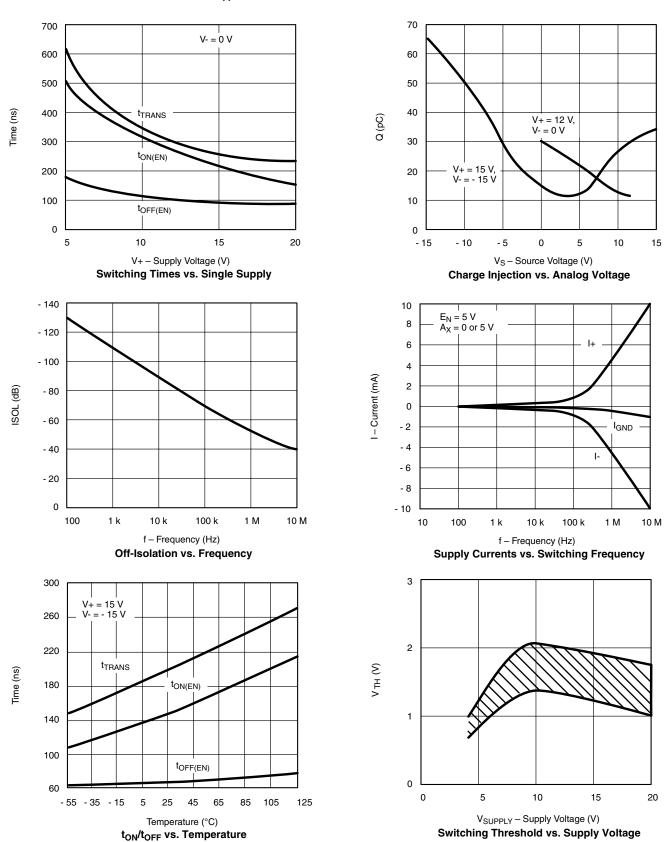
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TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted





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SCHEMATIC DIAGRAM (TYPICAL CHANNEL)

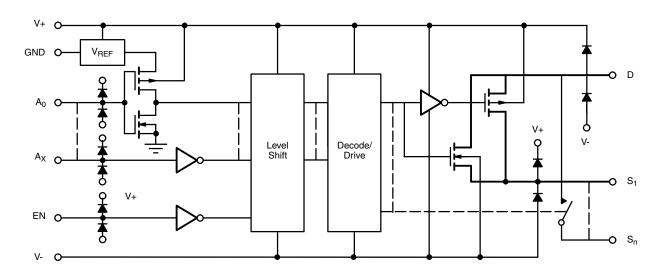


Figure 1.

TEST CIRCUITS

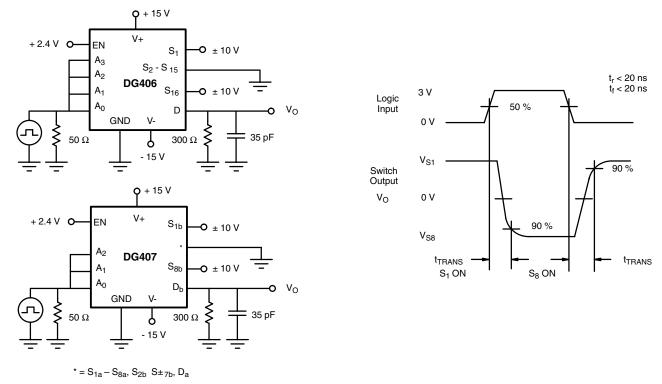


Figure 2. Transition Time



TEST CIRCUITS

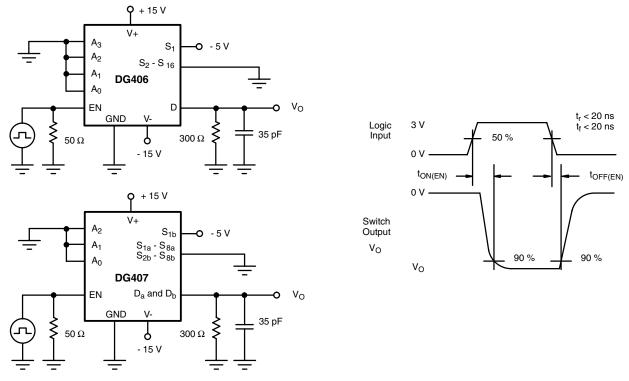


Figure 3. Enable Switching Time

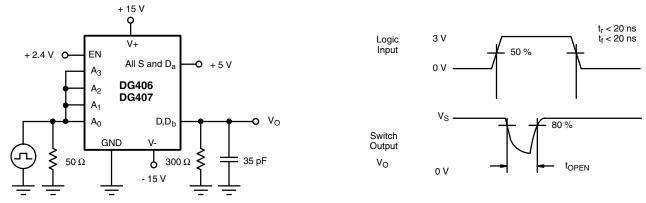


Figure 4. Break-Before-Make Interval

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APPLICATIONS HINTS

Sampling speed is limited by two consecutive events: the transition time of the multiplexer, and the settling time of the sampled signal at the output.

 t_{TRANS} is given on the data sheet. Settling time at the load depends on several parameters: $r_{DS(on)}$ of the multiplexer, source impedance, multiplexer and load capacitances, charge injection of the multiplexer and accuracy desired.

The settling time for the multiplexer alone can be derived from the model shown in Figure 5. Assuming a low impedance signal source like that presented by an op amp or a buffer amplifier, the settling time of the RC network for a given accuracy is equal to $n\tau$:

% ACCURACY	# BITS	N
0.25	8	6
0.012	12	9
0.0017	15	11

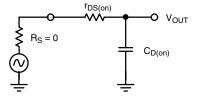


Figure 5. Simplified Model of One Multiplexer Channel

The maximum sampling frequency of the multiplexer is:

$$\begin{split} f_{s} &= \frac{1}{N(t_{SETTLING} + t_{TRANS})} \\ &\quad \text{where N = number of channels to scan} \\ &\quad t_{SETTLING} = n\tau = n \ x \ r_{DS(on)} \ x \ C_{D(on)} \end{split}$$

For the DG406 then, at room temp and for 12-bit accuracy, using the maximum limits:

$$f_s = \frac{1}{16 (9 \times 100 \Omega \times 10^{-12} F) + 300 \times 10^{-12} s}$$
 (2)

10

$$f_{s} = 694 \text{ kHz} \tag{3}$$

From the sampling theorem, to properly recover the original signal, the sampling frequency should be more than twice the maximum component frequency of the original signal. This assumes perfect bandlimiting. In a real application sampling at three to four times the filter cutoff frequency is a good practice.

Therefore from equation 2 above:

$$f_{c} = \frac{1}{4} \times f_{s} = 173 \text{ kHz}$$

$$\tag{4}$$

From this we can see that the DG406 can be used to sample 16 different signals whose maximum component frequency can be as high as 173 kHz. If for example, two channels are used to double sample the same incoming signal then its cutoff frequency can be doubled.



APPLICATIONS HINTS

The block diagram shown in Figure 6 illustrates a typical data acquisition front end suitable for low-level analog signals. Differential multiplexing of small signals is preferred since this method helps to reject any common mode noise. This is especially important when the sensors are located at a distance and it may eliminate the need for individual

amplifiers. A low r_{DS(on)}, low leakage multiplexer like the DG407 helps to reduce measurement errors. The low power dissipation of the DG407 minimizes on-chip thermal gradients which can cause errors due to temperature mismatch along the parasitic thermocouple paths. Please refer to Application Note AN203 for additional information.

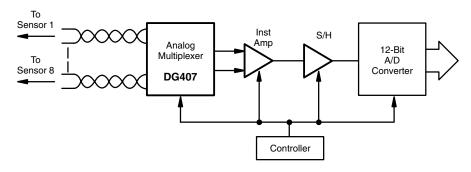


Figure 6. Measuring low-level analog signals is more accurate when using a differential multiplexing technique.

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